Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,126	LAI, JEN-SHOW	
Examiner	Art Unit	
David Buttner	1712	

SEARCHED				
Subclass	Date	Examiner		
		:		
-				
	Subclass	Subclass Date		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
528	all	11/17/2006	DB		
525	all	11/17/2006	DB		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
east	11/17/2006	DB	
invnetor search	11/17/2006	DB	